Studies of Growing La0.7Sr0.3MnO3 films on SrTiO3(110) substrate and of X-ray

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ABSTRACT

The target of this thesis is the La0.7Sr0.3MnO3(LSMO) film grow on the single crystal substrate of SrTiO3(110) with RF magnetron sputtering. This thesis also discusses the physics characteristics of La0.7Sr0.3MnO3(LSMO) film under different external applied magnetic field and temperatures. We use the powder X-ray diffraction -2 to analyze the structure of film crystal and to judge the growth direction of epitaxy vertical film surface. In addition, we utilize scan to analyze the arrangement direction of film surface and its order. This thesis divides into three parts. First of all, the results are the growth of LSMO film and the crystal structure analysis on STO(110) and STO(001). Secondly, it shows that how the different growth temperatures affect on LSMO characteristics. At last, it contains the discussion of the differences. 1. We can grow the preferred single crystal structure of LSMO film on STO(110). 2. There must be certain growth temperature is, the larger the surface roughness is. According to Scherrer Equation , it has the same result as the surface roughness because when the growth temperature is increased, the crystal is bigger. 3. The sample of LSMO film grows on STO(110) at 600 oC growth temperature and the external applied field is H=0.8 T. When it is under H//[10], I//[001], Tm is lower than it is under H//[001], I//[10]. It can be discovered that the Magnetoresistance ratio in the direction of [10] is higher than that in the direction of [001].

Keywords : Perovskite ; LaSrMnO ; Scan ; Bragg 's law ; RF magnetron sputtering ; Single crystal ; Magnetoresistance

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